



**Advanced Power  
Electronics Corp.**

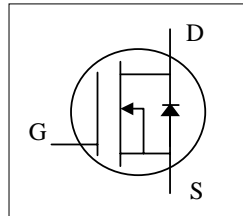
**AP9916GH/J**

**Pb Free Plating Product**

*N-CHANNEL ENHANCEMENT MODE*

*POWER MOSFET*

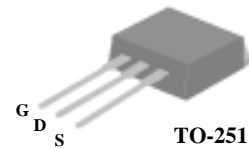
- ▼ Low on-resistance
- ▼ Capable of 2.5V gate drive
- ▼ Low drive current
- ▼ Surface mount package



$BV_{DSS}$	18V
$R_{DS(ON)}$	25m $\Omega$
$I_D$	35A

## Description

The Advanced Power MOSFETs from APEC provide the designer with the best combination of fast switching, ruggedized device design, ultra low on-resistance and cost-effectiveness.



## Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
$V_{DS}$	Drain-Source Voltage	18	V
$V_{GS}$	Gate-Source Voltage	$\pm 8$	V
$I_D @ T_C=25^\circ C$	Continuous Drain Current, $V_{GS} @ 4.5V$	35	A
$I_D @ T_C=125^\circ C$	Continuous Drain Current, $V_{GS} @ 4.5V$	16	A
$I_{DM}$	Pulsed Drain Current <sup>1</sup>	90	A
$P_D @ T_C=25^\circ C$	Total Power Dissipation	50	W
	Linear Derating Factor	0.4	W/ $^\circ C$
$T_{STG}$	Storage Temperature Range	-55 to 150	$^\circ C$
$T_J$	Operating Junction Temperature Range	-55 to 150	$^\circ C$

## Thermal Data

Symbol	Parameter	Value	Unit
Rthj-c	Thermal Resistance Junction-case	Max. 2.5	$^\circ C/W$
Rthj-a	Thermal Resistance Junction-ambient	Max. 110	$^\circ C/W$


**Electrical Characteristics @ $T_j=25^\circ\text{C}$  (unless otherwise specified)**

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	18	-	-	V
$\Delta BV_{DSS}/\Delta T_j$	Breakdown Voltage Temperature Coefficient	Reference to $25^\circ\text{C}, I_D=1\text{mA}$	-	0.03	-	$V/^\circ\text{C}$
$R_{DS(ON)}$	Static Drain-Source On-Resistance	$V_{GS}=4.5V, I_D=6A$	-	-	25	$\text{m}\Omega$
		$V_{GS}=2.5V, I_D=5.2A$	-	-	40	$\text{m}\Omega$
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu A$	0.5	-	1	V
$g_{fs}$	Forward Transconductance	$V_{DS}=10V, I_D=6A$	-	18	-	S
$I_{DSS}$	Drain-Source Leakage Current ( $T_j=25^\circ\text{C}$ )	$V_{DS}=18V, V_{GS}=0V$	-	-	25	$\mu A$
	Drain-Source Leakage Current ( $T_j=125^\circ\text{C}$ )	$V_{DS}=18V, V_{GS}=0V$	-	-	250	$\mu A$
$I_{GSS}$	Gate-Source Leakage	$V_{GS}=\pm 8V$	-	-	$\pm 100$	nA
$Q_g$	Total Gate Charge <sup>2</sup>	$I_D=18A$	-	17.5	-	nC
$Q_{gs}$	Gate-Source Charge	$V_{DS}=18V$	-	1.2	-	nC
$Q_{gd}$	Gate-Drain ("Miller") Charge	$V_{GS}=5V$	-	7.9	-	nC
$t_{d(on)}$	Turn-on Delay Time <sup>2</sup>	$V_{DS}=10V$	-	7.3	-	ns
$t_r$	Rise Time	$I_D=18A$	-	98	-	ns
$t_{d(off)}$	Turn-off Delay Time	$R_G=3.3\Omega, V_{GS}=5V$	-	25.6	-	ns
$t_f$	Fall Time	$R_D=0.56\Omega$	-	98	-	ns
$C_{iss}$	Input Capacitance	$V_{GS}=0V$	-	527	-	pF
$C_{oss}$	Output Capacitance	$V_{DS}=18V$	-	258	-	pF
$C_{riss}$	Reverse Transfer Capacitance	$f=1.0\text{MHz}$	-	112	-	pF

**Source-Drain Diode**

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
$I_S$	Continuous Source Current ( Body Diode )	$V_D=V_G=0V, V_S=1.3V$	-	-	35	A
$I_{SM}$	Pulsed Source Current ( Body Diode ) <sup>1</sup>		-	-	90	A
$V_{SD}$	Forward On Voltage <sup>2</sup>	$T_j=25^\circ\text{C}, I_S=35A, V_{GS}=0V$	-	-	1.3	V

**Notes:**

1. Pulse width limited by safe operating area.
2. Pulse width  $\leq 300\mu s$ , duty cycle  $\leq 2\%$ .

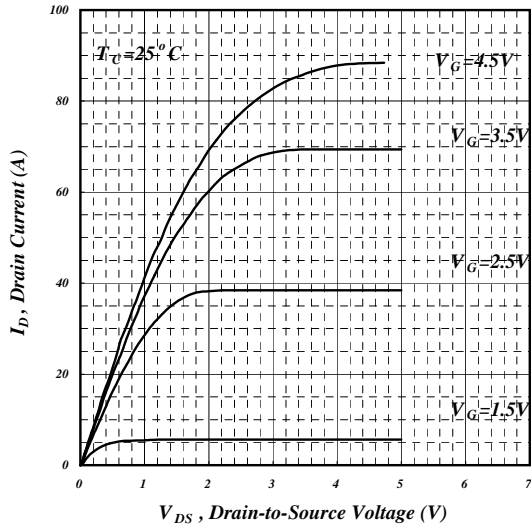


Fig 1. Typical Output Characteristics

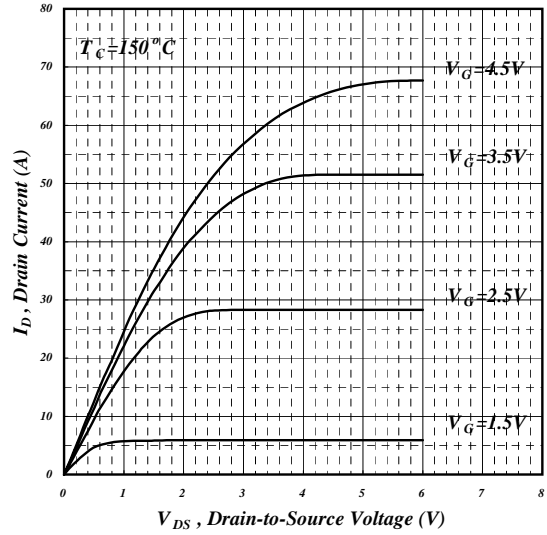
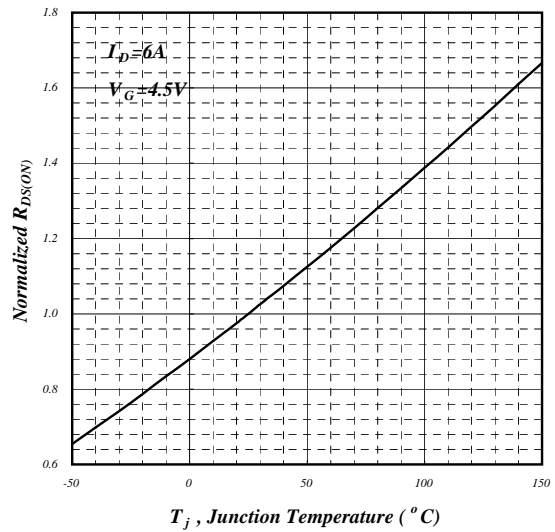
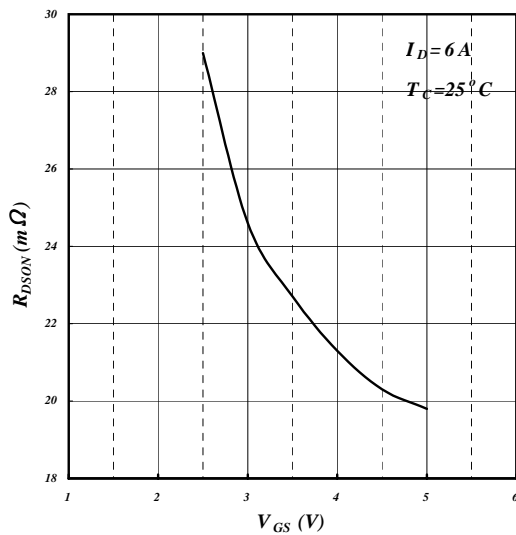


Fig 2. Typical Output Characteristics



v.s. Junction Temperature

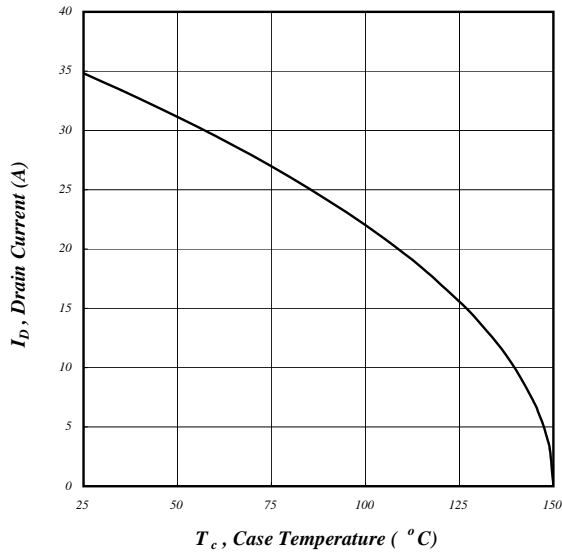


Fig 5. Maximum Drain Current v.s. Case Temperature

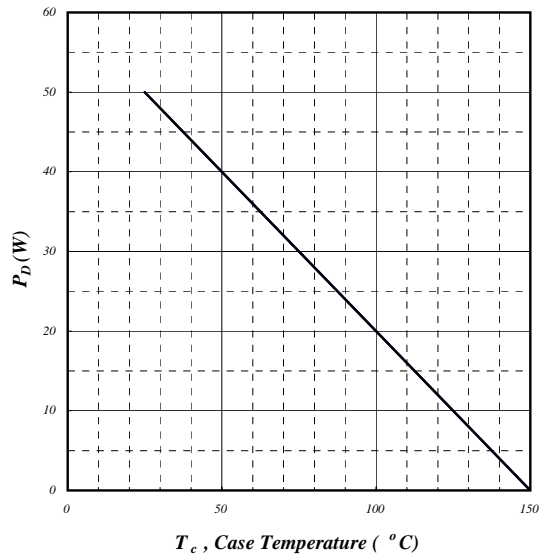
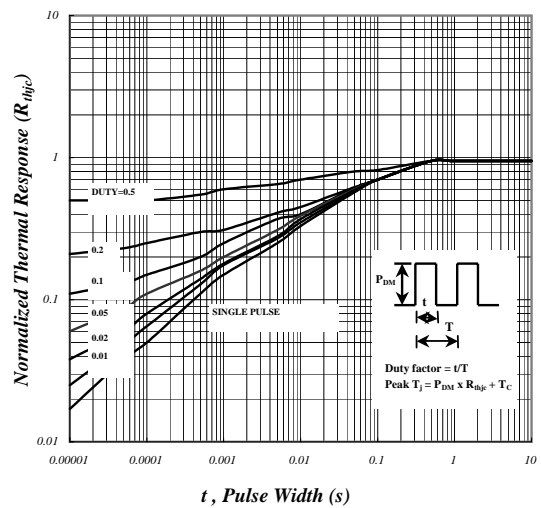
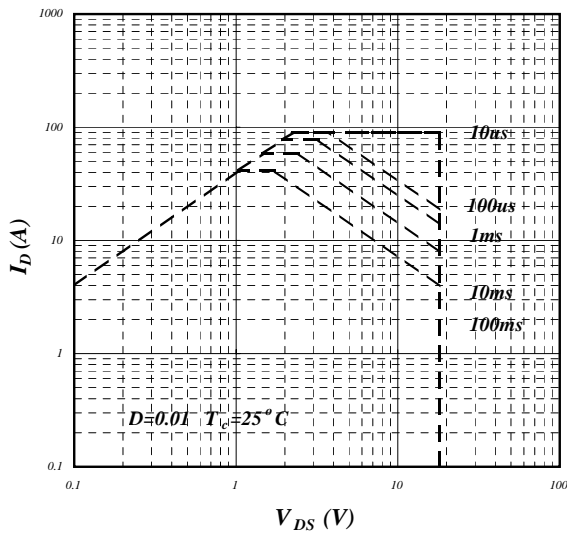


Fig 6. Typical Power Dissipation



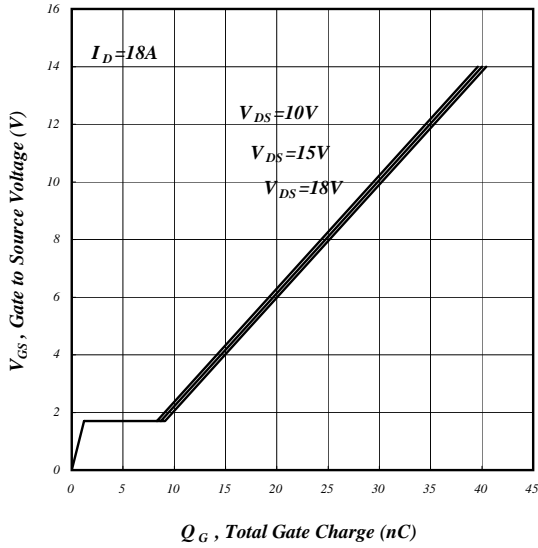


Fig 9. Gate Charge Characteristics

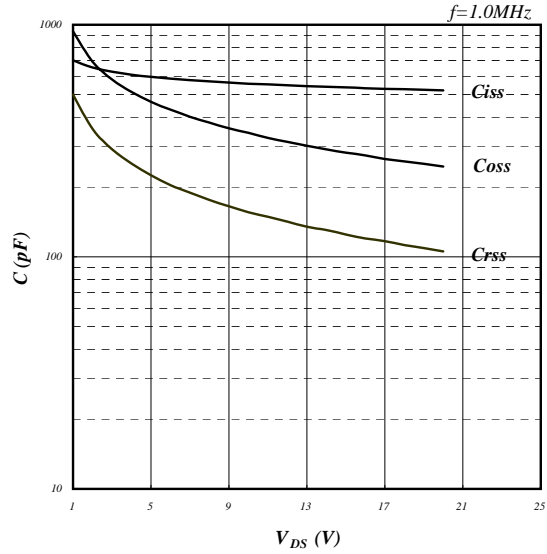
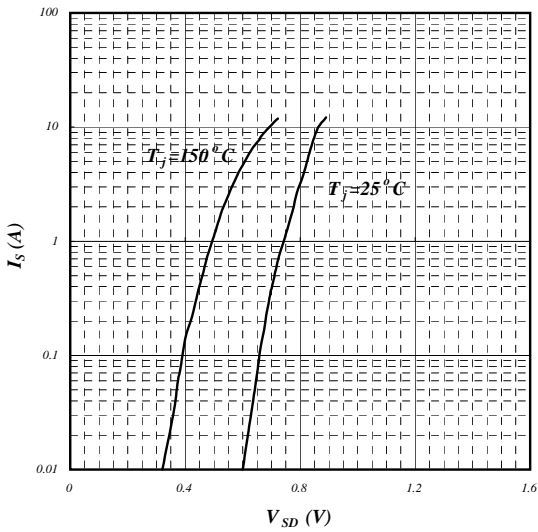
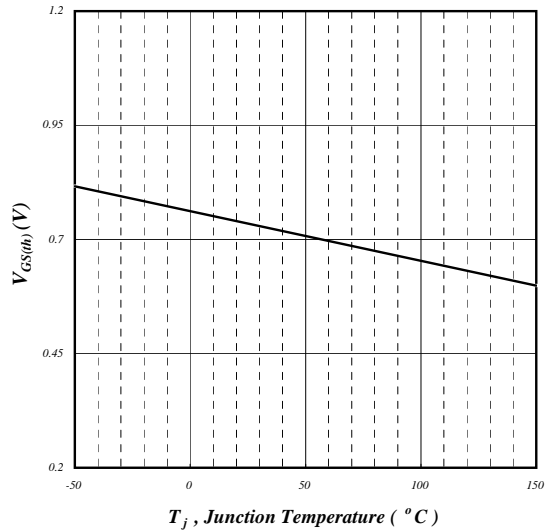


Fig 10. Typical Capacitance Characteristics



Reverse Diode



Junction Temperature

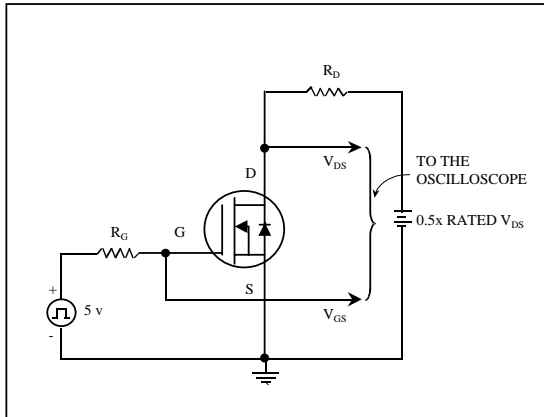


Fig 13. Switching Time Circuit

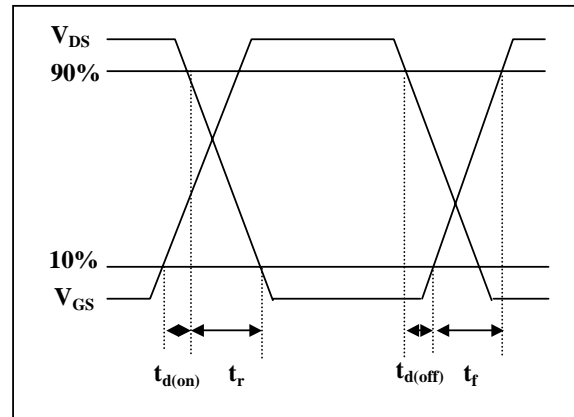


Fig 14. Switching Time Waveform

